

**Search Notes**

Application/Control No.

10/682,349

Examiner

Christopher B. Shin

Applicant(s)/Patent under  
Reexamination

ZAUDTKE ET AL.

Art Unit

2182

**SEARCHED**

Class	Subclass	Date	Examiner
235	462.15	6/15/2005	CBS
235	472.01	6/15/2005	CBS
341	176	6/15/2005	CBS
707	10,102	6/15/2005	CBS
707	201	6/15/2005	CBS
713	1-2, 100	6/15/2005	CBS
713	300-340	6/15/2005	CBS
710	1-5, 8	6/15/2005	CBS
710	14	6/15/2005	CBS

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
713	2,300	6/15/2005	CBS
710	10	6/15/2005	CBS
275	462.15	6/15/2005	CBS
472.01		6/15/2005	CBS

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
PALM FOR DOUBLE PATENTING	6/15/2005	CBS
PLUS	6/15/2005	CBS
EAST (USPGPUB, USPAT, USOCR EPO, JPO, DERWENT, IBM_TDB)	6/15/2005	CBS